An ISO/TS16949 and ISO 9001 Certified Company



## **SOT-23 Formed SMD Package**

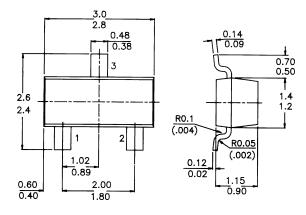
## **CMBT3905**

# SILICON EPITAXIAL TRANSISTOR

P-N-P transistor

**Marking** CMBT3905 = 2Y

PACKAGE OUTLINE DETAILS
ALL DIMENSIONS IN mm



### Pin configuration

1 = BASE

2 = EMITTER

3 = COLLECTOR



### ABSOLUTE MAXIMUM RATINGS

Collector-base voltage (open emitter)	$-V_{CBO}$	max.	40 V
Collector-emitter voltage (open base)	$-V_{CEO}$	max.	40 V
Emitter-base voltage (open collector)	$-V_{EBO}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation up to $T_{amb} = 60  ^{\circ}C$	$P_{tot}$	max.	250  mW
D.C. current gain			
$-I_C = 10 \text{ mA}; -V_{CE} = 1 \text{ V}$	$h_{FE}$	50 to	150
Transition frequency at $f = 100 \text{ MHz}$			
$-I_C = 10 \text{ mA; } -V_{CE} = 20 \text{ V}$	$f_T$	min.	200 MHz

## **CMBT3905**

<b>RATINGS</b> (at $T_A = 25^{\circ}C$ unless otherwise specified)			
Limiting values Collector-base voltage (open emitter)	$-V_{CB0}$	may	40 V
Collector–emitter voltage (open base)	-V CB0 -V CE0	max. max.	40 V 40 V
Emitter-base voltage (open collector)	$-V_{EB0}$	max.	5 V
Collector current (d.c.)	$-I_C$	max.	200 mA
Total power dissipation*	10	max.	200 1111
up to $T_{amb} = 25  ^{\circ}C$	$P_{tot}$	max.	250 mW
Storage temperature	$T_{Stg}$		+150 °C
THERMAL CHARACTERISTICS			
$T_j = P(R_{th j-t} + R_{th t-s} + R_{th s-a}) + T_{amb}$			
Thermal resistance			
from junction to ambient	$R_{th\ j-a}$	=	200 ℃W
nom function to unificial	run j-a		200 011
<b>CHARACTERISTICS</b> (at $T_A = 25^{\circ}C$ unless otherwise specifically s	ied)		
$T_{amb} = 25$ °C unless otherwise specified			
Collector-emitter breakdown voltage	* 7		40. 17
$-I_C = 1 \text{ mA; } l_B = 0$	$-V_{(BR)CE0}$	min.	40 V
Collector-base breakdown voltage	T 7		40. 17
$-I_C = 10\mu A; I_E = 0$	$-V_{(BR)CB0}$	mın.	40 V
Emitter-base breakdown voltage	17		F 17
$-I_E = 10 \mu A; I_C = 0$ Collector cut-off current	−V <sub>(BR)EB0</sub>	111111.	5 V
$-V_{CE} = 30 \ V; \ -V_{EB} = 3 \ V$	Lanu	may	50 nA
$-v_{CE} = 30 \text{ v}, -v_{EB} = 3 \text{ v}$ Base current	-I <sub>CEX</sub>	max.	JU IIA
with reverse biased emitter junction	$-I_{BEX}$	max.	50 nA
Output capacitance at $f = 100 \text{ kHz}$	<sup>1</sup> BEA	шах.	30 IL-1
$I_E = 0; -V_{CB} = 5 V$	$C_{c}$	max.	4.5 pF
Input capacitance at $f = 100 \text{ kHz}$	$c_c$	max.	1.0 pi
$I_C = 0; -V_{BE} = 0.5 V$	$C_{e}$	max.	10 pF
IC o, v <sub>BE</sub> o,o v	C e	111431.	10 p1
Saturation voltages			
$-I_C = 10 \text{ mA}; -I_B = 1 \text{ mA}$	$-V_{CEsat}$	max.	0,25 V
T 70 4 T 7 A	* 7		0.4.17
$-I_C = 50 \text{ mA}; -I_B = 5 \text{ mA}$	-V <sub>CEsat</sub>	max.	0,4 V
$-I_C = 10 \text{ mA}; -I_B = 1 \text{ mA}$	-V <sub>BEsat</sub>	min.	0,65 V
	DESCR	max.	0,85 V
			.,
$-I_C = 50 \text{ mA}; -I_B = 5 \text{ mA}$	-V <sub>BEsat</sub>	max.	0,95 V
D.C. current gain			
$-I_C = 0.1 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{FE}$	min.	30
$-I_C = 1 \text{ mA; } -V_{CE} = 1 \text{ V}$ $-I_C = 1 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{FE}$	min.	40
10 - 1 mm, -v CE - 1 v	11FE	111111.	70
$-I_C = 10 \text{ mA}; -V_{CE} = 1 \text{ V}$	$h_{FE}$	min.	50
		max.	150

#### **CMBT3905**

$-I_C = 50 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{\!F\!E}$	min.	<i>30</i>
$-I_C = 100 \text{ mA; } -V_{CE} = 1 \text{ V}$	$h_{FE}$	min.	15
Transition frequency at $f = 100 \text{ MHz}$			
$-I_C = 10mA; -V_{CE} = 20V$	$f_T$	min.	200 MHz
Noise figure at $R_S = 1 k\Omega$			
$-I_C = 100 \mu A; -V_{CE} = 5 V$			
f = 10  Hz to  15.7  kHz	F	max.	4 dB
Small Signal Current Gain			
$-V_{CE} = 10V$ ; $-I_{C} = 1$ mA; $f = 1$ KHz	$h_{fe}$	min.	<i>50</i>
		max.	200

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